<specification></specification>
SPEC.No. ASDIQ-SPE-039(00) Date: Jan. 6, 2022
То :
CUSTOMER'S PRODUCT NAME
ASDI PRODUCT NAME: AMPI4012B-Series
RECEIPT CONFIRMATION
UNCONDITIONAL CONSENT CONDITIONAL CONSENT
APPROVED CHECKED
ASDI SIGNATURE
APPROVED CHECKED PREPARED Xianglong Li Liang Wang Jiayin Cai



REV.	DATE	DESCRIPTION	APPROVED	CHECKED	PREPARED
00	Jan. 6, 2022	New release	Xianglong Li	Liang Wang	Jiayin Cai

CAUTION WHEN HANDLING

Before use the products, please read this specification.

CAUTION FOR SAFETY USING

When use the products, be careful to mentioned below for safety using.

CUSTOMER	ASDI PART No.	CUSTOMER'S DWG NO.
Each Corporation	AMPI4012B-Series	

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2.Manufacturing Location

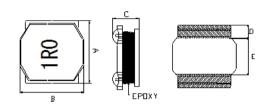
China

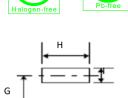
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(1)Features

1.This specification applies Low Profile Power Inductors. 2.100% Lead(Pb) & Halogen-Free and RoHS compliant.

(2)Dimensions







								Units: mm
Series	A(mm)	B(mm)	C(mm)	D(mm)	E(mm)	G(mm)	H(mm)	l(mm)
AMPI4012B	4.0±0.2	4.0±0.2	1.2 max.	1.2ref.	1.8ref.	2.8 ref.	3.7 ref.	1.2 ref.

(3)Part Numbering

AMPI A	4012 B	B C	-	2R2 D	M E
A: Series B: Dimension C: Control S/N					
		000 0	o 11		

D: Inductance E: Inductance Tolerance $\begin{array}{l} 2\text{R2=2.2}\mu\text{H} \\ \text{M=}\pm20\%; \ \text{N=}\pm30\%; \end{array}$

(4)Electrical Specifications

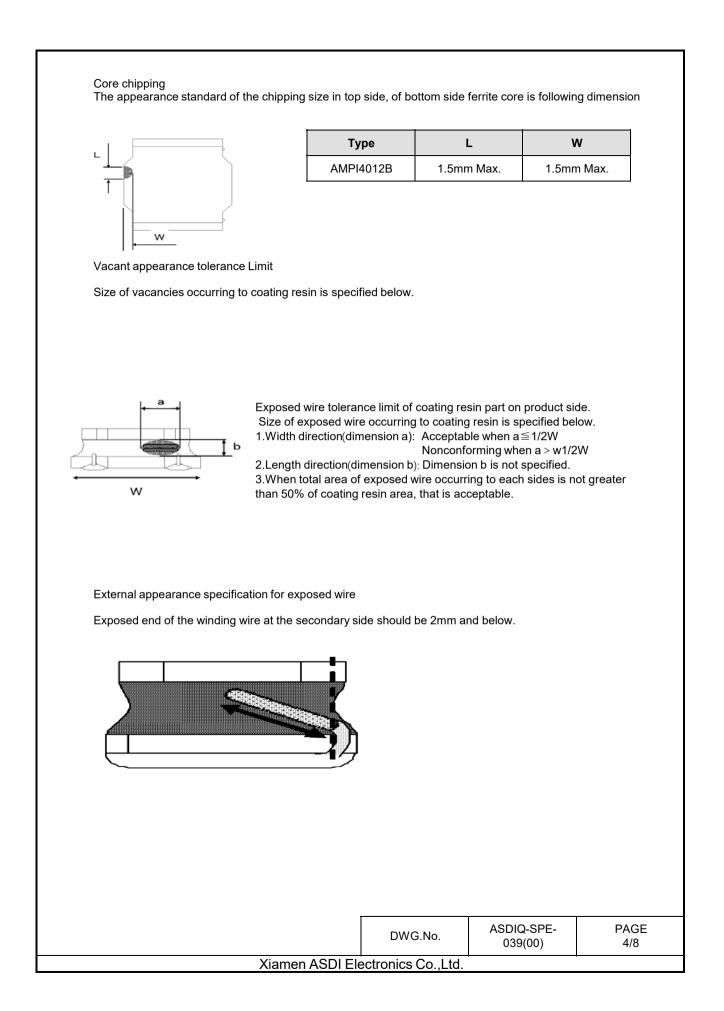
Table 1

ASDI Part Number	Inductance (µH)	Tolerance (%)	Test Frequency (Hz)	SRF (MHz) min.	DCR (Ω) ±30%	l sat (A)	l rms (A)
AMPI4012B-1R0N	1.0	±30%	100kHz/1V	100.0	0.042	2.80	2.20
AMPI4012B-2R2M	2.2	±20%	100kHz/1V	70.0	0.060	1.65	1.90
AMPI4012B-3R3M	3.3	±20%	100kHz/1V	60.0	0.070	1.40	1.70
AMPI4012B-4R7M	4.7	±20%	100kHz/1V	45.0	0.095	1.20	1.50
AMPI4012B-6R8M	6.8	±20%	100kHz/1V	35.0	0.125	0.90	1.30
AMPI4012B-100M	10.0	±20%	100kHz/1V	30.0	0.170	0.80	1.10
AMPI4012B-150M	15.0	±20%	100kHz/1V	24.0	0.260	0.65	0.75
AMPI4012B-220M	22.0	±20%	100kHz/1V	18.0	0.400	0.50	0.62

Note:

lsat: Based on inductance change (\triangle L/L0: \leq -30%) @ ambient temp. 25°C Irms: Based on temperature rise (△T: 40℃ typ.)

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(5)Material List

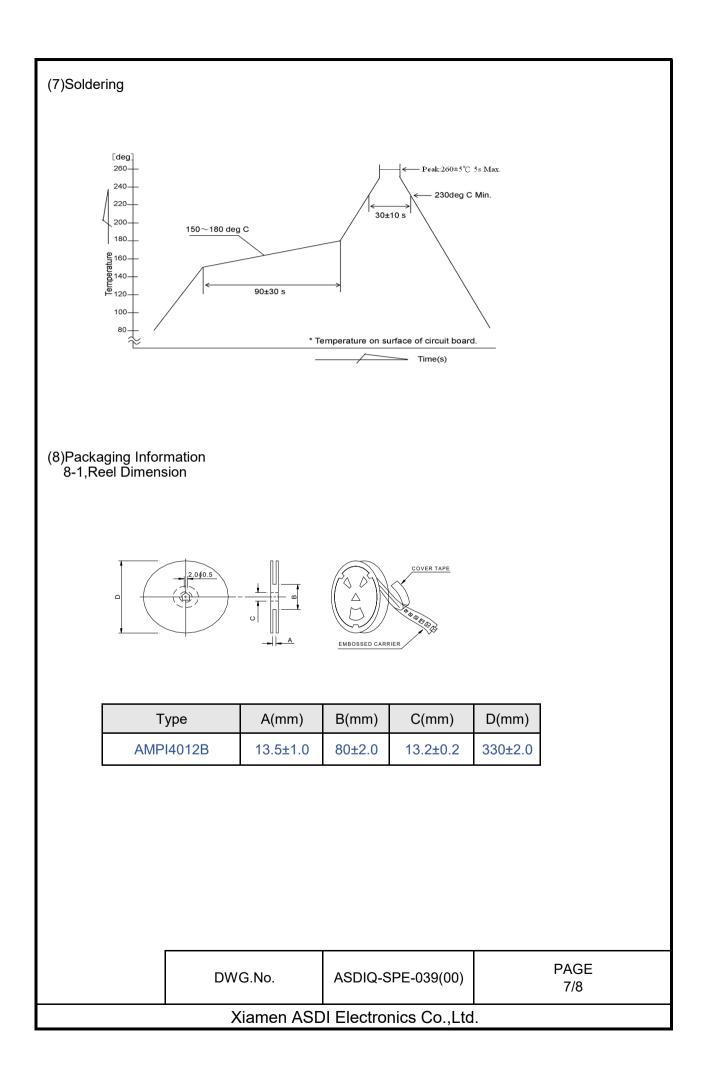
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(4)

	NO	Items	Materials
	1	Core	Ni-Zn ferrite
	2	Wire	Copper Wire
	3	Coating	Ероху
)	4	Solder	Lead free

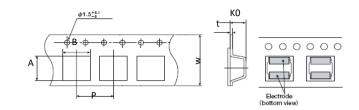
(6)Reliability tests

No.	Test item	Performa	ance	Test details	i	
1	Operating	- 25 ~ +12	25℃ .	Including self-generated heat		
	temperature Storage					
2	temperature and Humidity range	-40 ~ +85℃. - 5 to 40℃ for the product with taping.				
3	Rated current					
4	Inductance (L)	Within the specified tolerance		LCR Meter: HP 4285A or equ 1V	iivalent, 100kHz	
5	DC Resistance			DC Ohmmeter: HIOKI3227 or	r equivalent	
6	Temperature characteristics	Inductance change: Within±20%		temperature rang within–25 °C With reference to inductance °C,change rate shall be calcu Measurement of inductance s temperature rang within–40 °C With reference to inductance	Measurement of inductance shall be taken a temperature rang within-25°C to +85°C. With reference to inductance value at+20 °C,change rate shall be calculated. Measurement of inductance shall be taken a temperature rang within-40°C to +125°C. With reference to inductance value at+20 °C,change rate shall be calculated.	
7	Resistance to flexure substrate	No damage		The test samples shall be sol testing board by the reflow. As illustrated below, apply for direction of the arrow indicati of the test board reaches to 2 Force 10 Force 10 Fo	ce in the ng until deflection mm.	
8	Adhesion of Terminal electrode	Shall not come off PC board.		testing board and by the reflo 10 N, 5 s Applied force: 10 N to X and Duration: 5s	Applied force: 10 N to X and Y directions.	
9	Resistance to Vibration	Inductance change: Within±10% No abnormality observed in appearance.		board by the reflow. Then it shall be submitted to l conditions. Frequency: 10-55Hz Total Amplitude: 1.5mm (May acceleration 196m/S2) Sweeping Method:10Hz to 55 1min. Time: 2 hours each in X,Y, a Recovery: At least 2hrs of rec standard condition after the te	Then it shall be submitted to below test conditions. Frequency: 10-55Hz Total Amplitude: 1.5mm (May not exceed acceleration 196m/S2) Sweeping Method:10Hz to 55Hz to 10Hz for	
					PAG	
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No.	Test item	Performance	Test details		
10	Solderability	At least 90% of surface of terminal electrode is covered by new solder.	The test samples shall be dipped in flux, and then immersed in molten solder as shown in below. Flux: methanol solution containing rosin 25% Solder temperature: 245±5°C Time: 5±1.0 sec. Immersion depth: All sides of mounting terminal shall be immersed.		
11 Resistance to soldering		Inductance change:Within±10% No abnormality observed in appearance.	The test sample shall be exposed to reflow oven a 230±5℃ for 40 seconds, with peak temperature a 260±5℃ for 5 seconds,2 times. Test board thickness: 1.0mm Test board material: glass epoxy-resin		
12	Thermal shock	Inductance change:Within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed at specified temperature for specified time by step 1 to step 4 as shown below in sequence. The temperature cycles shall be repeated 100 cycles . $\frac{Phase Temperature(C) Time(min.)}{1 - 40.43^{\circ}C} - 30.43$ $\frac{2}{3} - 85.42^{\circ}C} - 30.43$ $\frac{3}{4} - 80.000 \text{ Temp} - Within 3$		
13	Damp heat life test		Test Method and Remarks The test samples shall be soldered to the test board by the reflow. The test samples shall be placed in thermostatic oven set at specified temperature and humidity as shown in below. Temperature: 60±2 °C Humidity: 90~95%RH Time: 500+24/-0 hrs		
14	Loading under damp heat life test	nductance change:Within±10% No abnormality observed in appearance.	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current continuously as shown in below. Temperature: 60±2 °C Humidity: 90~95%RH Applied current: Rated current Time: 500+24/-0 hrs		
15	Low temperature life test		e test samples shall be soldered to the test ard by the reflow. er that, the test samples shall be placed at test diftions as shown in below. mperature:-40±2°C ne:500+24/-0 hrs		
16	Loading at high temperature life test		The test samples shall be soldered to the test board by the reflow. Temperature: 85±2°C. Applied current: Rated current Time: 500+24/-0 hrs.		
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8-2, Tape Dimension



Series	A(mm)	B(mm)	Ko(mm)	P(mm)	W(mm)	t(mm)
AMPI4012B	4.3±0.1	4.3±0.1	1.6±0.1	8.0±0.1	12.0±0.3	0.3±0.05

8-3, Packaging Quantity

Туре	Chip / Reel	
AMPI4012B	4000	

(9)Note

·Storage Conditions

To maintain the solderability of terminal electrodes:

1. ASDI products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.

2. Temperature and humidity conditions: Temperature: 5 to 30deg.C, Humidity: 75% Max.

3. Recommended products should be used within 12 months form the time of delivery.

4. The packaging material should be kept where no chlorine or sulfur exists in the air.

·Transportation

1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.

2. The use of tweezers or vacuum pick up is strongly recommended for individual components.

3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

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单击下面可查看定价,库存,交付和生命周期等信息

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